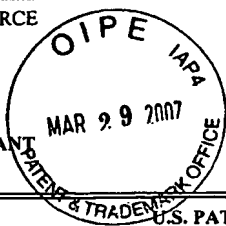


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							YES	NO
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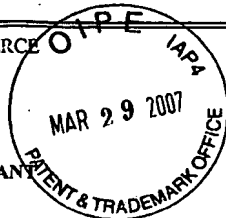
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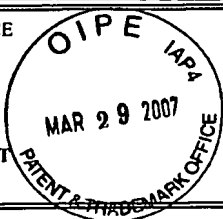
Mark L. Shin

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MS	AM	11-229083	08/24/99	Japan			Abstract Only	
MS	AN	2000-336456 A	12/05/00	Japan			Abstract Only	
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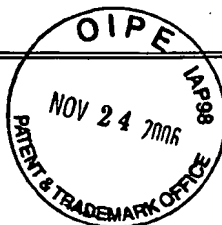
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MS	AN	EP 0924312 A	06/23/99	Europe				
MS	AO	EP 1281782 A	02/05/03	Europe				
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	AP							

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